

**Notice of References Cited**

Application/Control No.

10/518,915

Applicant(s)/Patent Under  
Reexamination  
YANO ET AL.

Examiner

Amy L. Clark

Art Unit

1655

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,747,049	05-1998	Tominaga, Naoki	424/401
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	JP 10017459 A	01-1998	Japan	KITADA et al.	
*	O	JP 08109122 A	04-1996	Japan	ITO et al.	
*	P	JP 05032537 A	02-1993	Japan	MATSUI et al.	
	Q	JP 10017458 A	01-1998	Japan	KITADA et al.	
*	R	JP 11228437 A	08-1999	Japan	FUJITANI et al.	
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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